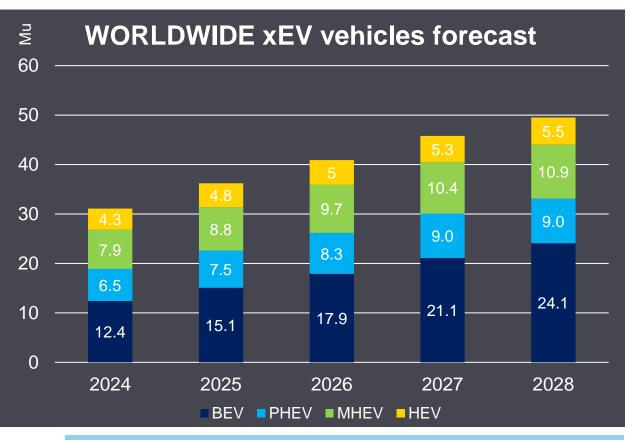
### Automotive Intelligent and Integrated GaN STi<sup>2</sup>GaN



## Automotive trends and GaN domains



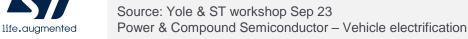
Forec	ast 800V	' system	produc	tion in l	ight duty	/ BEV
11%	14%	16%	18%	21%	25%	27%
2024	2025	2026	2027	2028	2029	2030

Application trends	Requirements
Smaller/lighter systems	High frequency operation
Higher driving range	Higher system efficiency
Greater ADAS level	Systems/sensor redundancy

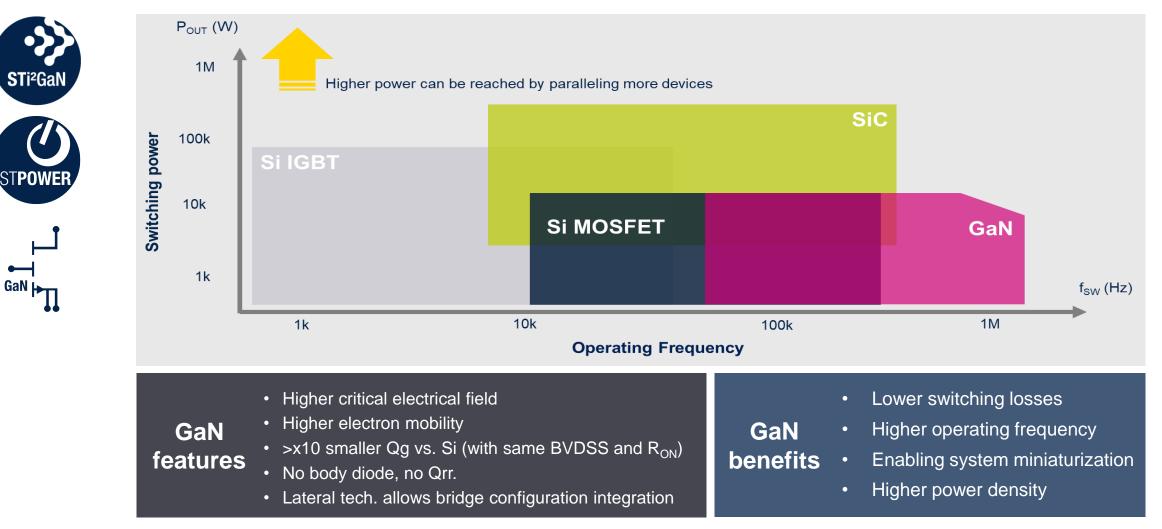
### Applications augmented by GaN technology

100 V domain	•	Centralized DC-DC & POL Class-D audio amplifier Lidar & motor control	
650 V domain	•	On-board charger HV to LV DC-DC converter Emergency power supply	





## Gallium nitride (GaN) technology



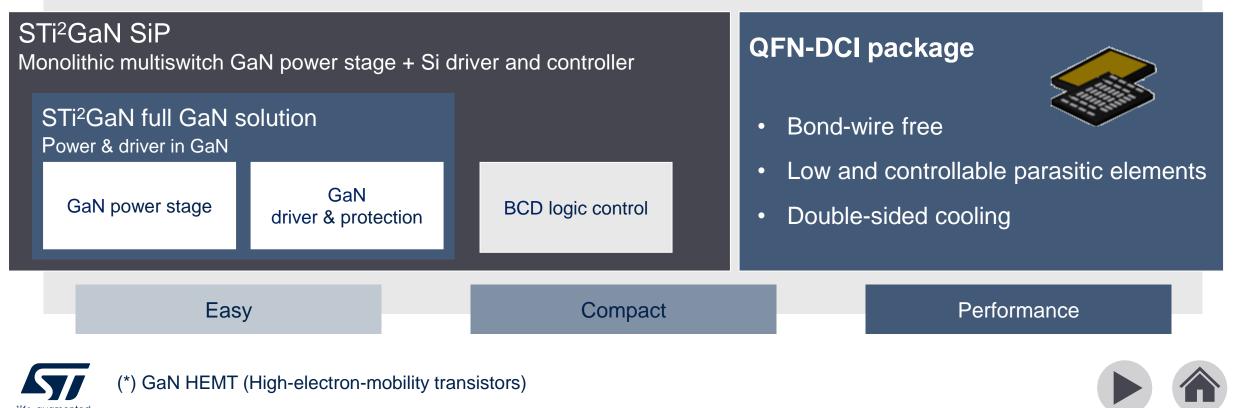




## STi<sup>2</sup>GaN smarter power electronics

STi<sup>2</sup>GaN solutions range from monolithic power stage plus driver to full control logic integration

Easily integrate full GaN performance in innovative, robust, and reliable bond-wire free packages





## STi<sup>2</sup>GaN lowers stray inductances

DRAIN

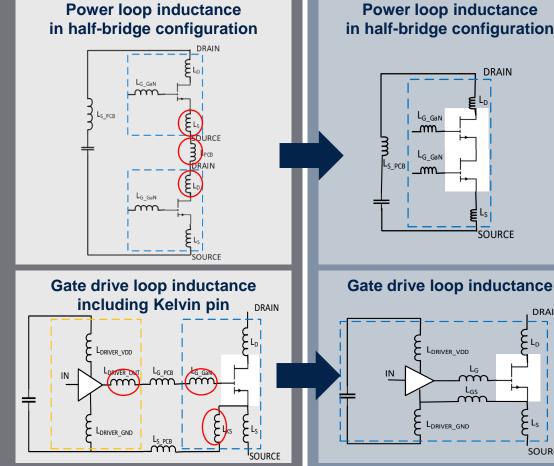
SOURCE

### **Discrete GaN solution**

### **Stray inductance:**

- In power loop causes higher voltage spikes and limits switching speed
- In gate drive loop causes gate ringing, increases false turn-ons and gate stress (SOA violation of the gate)

**Higher development effort:** Require a gate dumping resistor and a multilayer PCB with optimized layout to reduce the effects of stray inductance



#### **Power loop inductance** in half-bridge configuration

## DRAIN SOURCE

### Integrated GaN solution

Lower stray inductance in the power loop drastically reduces  $V_{DS}$ spikes:

- Lower switching losses
- Lower EMI
- Lower  $V_{DS}$  voltage stress

Very low gate drive loop stray inductance vastly reduces V<sub>GS</sub> ringing:

- Improved reliabilit thanks to lower stress on gate structure
- thanks to lower dumping resistance on driver output

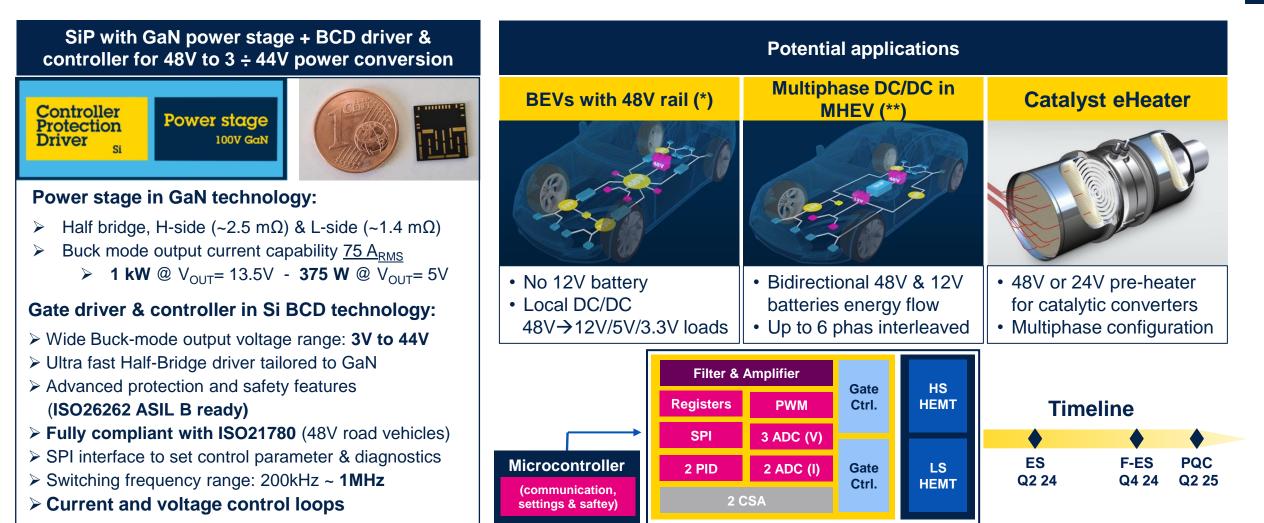








## 100 V IG1BC01A – Bidirectional DC/DC converter







## IG1BC01A – Application architecture

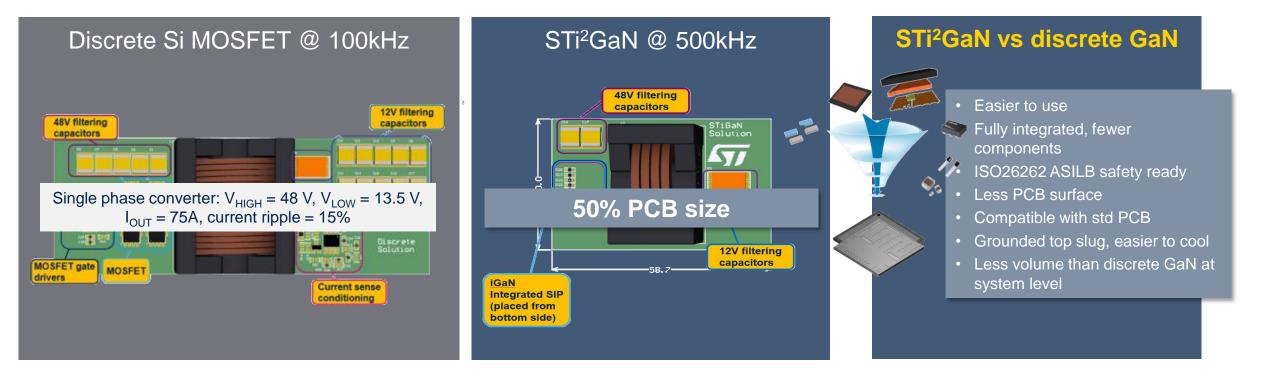
48V Centralized architecture	re Current regulator, with up to 6 interleaved phases:							
	<ul> <li>External CPU should supply the PWM Clock signal and set up the following operating parameters:</li> <li>Current Setpoint – same for all ICs for a better system performance</li> <li>VHIGH or VLOW desired threshold limit</li> <li>Positional number of each specific phase IC (Ni) within the interleaving sequence.</li> <li>Number of active phases (N) → All phases with Ni &gt; N are disabled</li> <li>The device is able to work either as a Buck (Current setpoint&gt; 0) or Boost (Current setpoint &lt; 0) regulator, specifically working as a current regulator with a "Voltage Limit" operation.</li> </ul>							
48V Distributed architecture	Single phase voltage or current regulator:							
	<ul> <li>V<sub>HIGH</sub>, V<sub>LOW</sub>, and current setpoint</li> <li>Number of active phases equal to '1' (N = 1)</li> <li>Positional number of the interleaving sequence equal to '1' (Ni = 1)</li> <li>For voltage regulation: the user should set V<sub>HIGH</sub> or V<sub>LOW</sub> setpoint, fixing the current setpoint at a value higher than the expected output current, thus acting as a safety current limitation. An additional security layer can be added by programming the overcurrent protection thresholds via SPI. For current regulation: the user should set the required current setpoint, fixing the VHIGH or VLOW setpoint at a value higher than the expected output voltage, thus acting as a safety voltage limitation.</li> </ul>							
48V Input		STi <sup>2</sup>	GaN - IG1BC	C01A		Storage		
EMI Filter Safety Switch		Filter & Amplifier		Gate Ctrl.		Inductor	12V Output	
Transient Protect. Reverse Polarity	Microcontroller	Regulation 3x PID	PWM Generator	LS Transistor HS Transistor	+	Buffer Capacitor	┢	EMI Filter Safety switch
Power Supply		Register	2x ADC (V)	Gate Ctrl.		Sense		Transient protect.
CAN / CAN FD 3.3V / 5V	(communication, settings & saftey)	SPI	2x ADC (I)	2 x CSA		Resistor		Reverse polarity





## 100 V IG1BC01A bidirectional DC-DC converter Application advantages

More compact and more efficient than discrete MOSFET solutions, and comparable in terms of cost





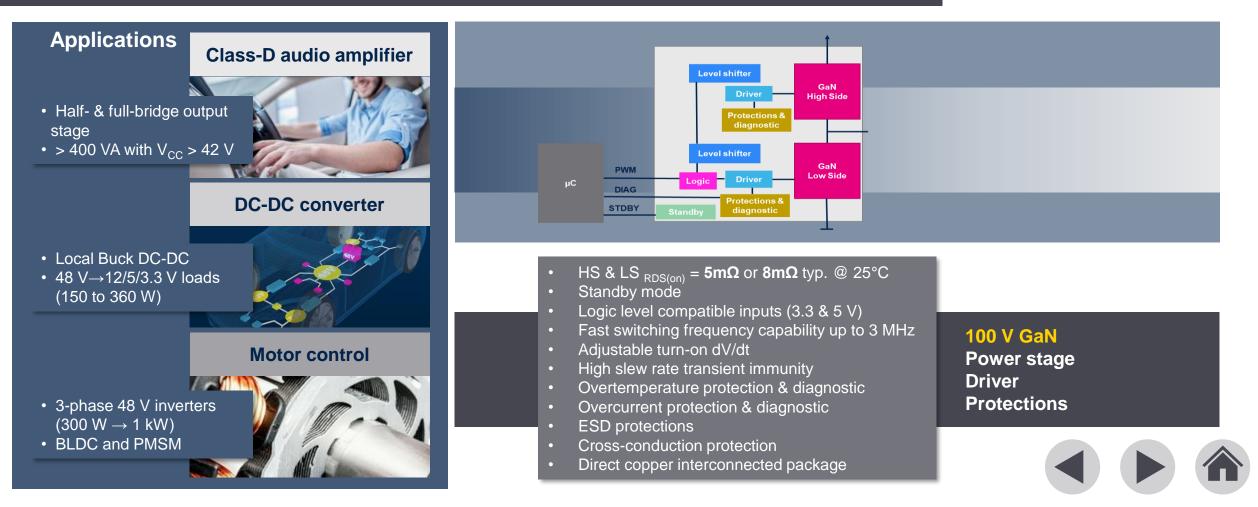


# 100 V STi<sup>2</sup>GaN full GaN half bridge IG1HB5RA (5 m $\Omega$ ) & IG1HB8RA (8 m $\Omega$ )

100 V e-GaN half bridge with drivers, level shifter, protections, and diagnostic

STi<sup>2</sup>GaN

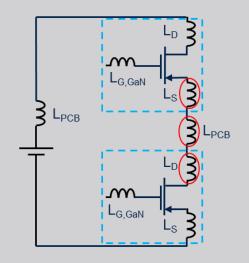
GaN Class-D demonstrator development ongoing



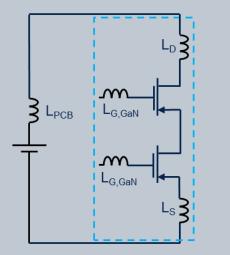


# IG1HB01A monolithic half bridge 2.2 m $\Omega$ HS and 1.2 m $\Omega$ LS

Discrete approach



### Monolithic approach



- HS R<sub>DS(on)</sub> = **2.2 mΩ** typ. at @ 25°C
- LS R<sub>DS(on)</sub> = **1.25 mΩ** typ. at @ 25°C
- High frequency operation above 1 MHz
- Extremely low R<sub>DS(on)</sub>
- Low EMIs
- Zero reverse recovery charge
- Available in direct copper interconnected bond-wire free package for high-frequency and high-power operation
- Dual-side cooling
- Monolithic approach, supporting discrete implementation for DC-DC conversion: lower stray inductance in power loop

